	Тур	Hi ts	Search Text	DBs	Time Stamp	m m e n	e f i n	Errors
1	BRS	31	temperature and gas and		2004/06/26 03:09			0
2	BRS	20	(process\$6 or react\$6) near chamber and vaccum and temperature and gas and (substrate or wafer) with hold\$6 with heat\$6 and (hf or nh3)		2004/06/25 00:39			O
3	IS& R	2	("5344522").PN	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/06/26 03:13			0
4	BRS	31	(process\$6 or react\$6) near chamber and vaccum and temperature and gas and (substrate or wafer) with hold\$6 with heat\$6	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/25 00:32			0

	Тур	Hi ts	Search Text	DBs	Time Stamp	m m e	ErrorDefinitio	E r r
5	BRS	0	and control\$6 and gas and		2004/06/25 00:41			Ο
6	BRS	13	treat\$6 and chamber and vaccum and temperature and control\$6 and gas and (substrate or wafer) with hold\$6 and (hfor nh3)	1	2004/06/25 00:42			0
7	BRS			USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/25 00:42			0

	Тур	Hi ts	Search Text	DBs	Time	Stamp	m m e	r D e f	E r o r
8	BRS	0	(process\$6 or react\$6) and wash\$6 near chamber and vaccum and temperature and gas and (substrate or wafer) near hold\$6 near heat\$6		2004/ 03:11	′06/26 -			Ο
9	BRS	0	wash\$6 near chamber and vaccum and temperature and gas and (substrate or wafer) near hold\$6 near heat\$6		2004/ 03:12	(06/26			0
10	BRS	0	wash\$6 and chamber and vaccum and temperature and gas and (substrate or wafer) with hold\$6 with heat\$6 with temperature with control\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/ 03:13	(06/26 3			0
11	IS& R	2	("5344522").PN	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/ 03:13	06/26			0
12	BRS	39	chamber and vaccum and temperature and gas and (substrate or wafer) with hold\$6 with heat\$6	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/ 08:06	06/26			0

	Тур	Hi ts	Search Text	DBs	Time Stamp	m m e	D e f i	E r r
13	BRS	2	wash\$6 and chamber and vaccum and temperature and gas and (substrate or wafer) with hold\$6 with heat\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/26 03:18			0
14	BRS			USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/26 08:04			0
15	IS& R	2	("5254505").PN	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/06/26 08:04			0
16	BRS	39	chamber and vaccum and temperature and gas and (substrate or wafer) with hold\$6 with heat\$6	IBM_TDB USPAT; US-PGPUB; EPO;	2004/06/26 08:08			0
17	BRS	2	and das and	1	2004/06/26 08:08			0